Search N	Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/731,874	LAH, RUBEN F.	
Examiner	Art Unit	Ī
Alexa D. Neckel	1764	

	SEARCHED		
Class	Subclass	Date	Examiner
Updated	Search	10/11/2006	ADN
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TMI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH (INCLUDING SEAI)
	DATE	EXMR
Updated Search	10/11/2006	ADN
Reviewed Applications: 10412628 10983417 11111480 11151055 11245384 11396982	10/11/2006	ADN